

Description

The AOTF13N50 can be used in various power swithching circuit for system miniaturization and higher efficiency. The package form is TO-220/TO-220F, which accords with the RoHS standard.



TO-220F

General Features

 $V_{DS} = 500V, I_{D} = 13A$ $R_{DS(ON)} < 0.48 \Omega@ V_{GS} = 10V$

PIN1 G PIN3 S

Application

• Power switch circuit of adaptor and charger.

N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Marking	Units Tube
AOTF13N50	TO-220F	13N50 XXX YYYY	50

Absolute Maximum Ratings@T =25°C(unless otherwise specified)

Symbol	Parameter	Limit	Unit		
V _{DSS}	Drain-to-Source Voltage ^[1]	500	V		
V _{GSS}	Gate-to-Source Voltage	±30	7 '		
I _{D @ Tc =100℃}	Continuous Drain Current @ Tc=100℃	13	Α		
I _{DM}	Pulsed Drain Current at V _{GS} =10V ^[2]	52			
E _{AS}	Single Pulse Avalanche Energy	900	mJ		
P_D	Power Dissipation	48	W		
T _L T _{PAK}	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260	$^{\circ}$		
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 150			
R _{θJC}	Thermal Resistance, Junction-to-Case	2.6	°C AA/		
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	™ °CM		

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.



Electrical Characteristics $T_J = 25^{\circ}\mathbb{C}$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	
BV _{DSS}	Drain-to-Source Breakdown Voltage	500			V	V_{GS} =0V, I_D =250uA	
	Drain-to-Source Leakage Current			1	uA	V_{DS} =500V, V_{GS} =0V	
I _{DSS}				100		V_{DS} =400V, V_{GS} =0V, T_J =125 $^{\circ}$ C	
I _{GSS}	Gate-to-Source Leakage Current			+100	nA ·	V_{GS} ==30V, V_{DS} =0V	
				-100		V _{GS} =-30V, V _{DS} =0V	
R _{DS(ON)}	Static Drain-to-Source On-Resistance		0.40	0.48	Ω	V _{GS} =10V, I _D =6.5A	
$V_{GS(TH)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}$, $I_{D}=250uA$	
gfs	Forward Transconductance		15		S	VDS=30V,ID=13A	
C _{iss}	Input Capacitance		2150			V_{GS} =0V, V_{DS} =25V, f=1.0MH _Z	
C _{rss}	Reverse Transfer Capacitance		23		pF		
C _{oss}	Output Capacitance		210				
Qg	Total Gate Charge		45			V _{DD} =250V, I _D =13A, V _{GS} =0 to 10V	
Q _{gs}	Gate-to-Source Charge		10		nC		
Q _{gd}	Gate-to-Drain (Miller) Charge		18			,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	
td(ON)	Turn-on Delay Time		15				
trise	Rise Time		25			V_{DD} =250V, I_{D} =13A, V_{GS} =10V Rg=6.1 Ω	
td(OFF)	Turn-Off Delay Time		45		ns		
tfall	Fall Time		35				
I _{SD}	Continuous Source Current ^[2]			13	Α	Integral pn-diode in MOSFET	
I _{SM}	Pulsed Source Current ^[2]			52	A		
V _{SD}	Diode Forward Voltage			1.5	V	I _S =13A, V _{GS} =0V	
trr	Reverse Recovery Time		500		ns	Vgs=0V	
Qrr	Reverse Recovery Charge		4.0		uC	I _F =13A, di/dt=100A/μs	

Note:

[1] T_J =+25°C to +150°C [2] Pulse width≤380 μ s; duty cycle≤2%.

Typical Characteristics

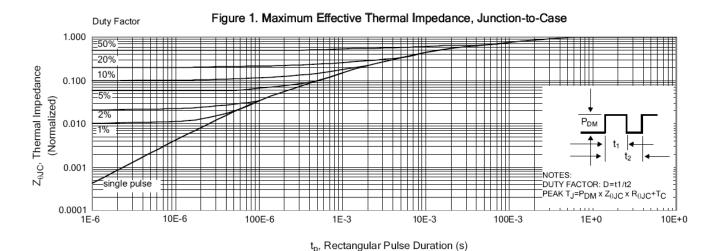


Figure 2. Maximum Power Dissipation vs Case Temperature

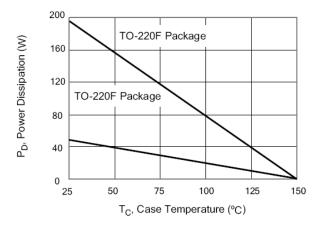


Figure 4. Typical Output Characteristics

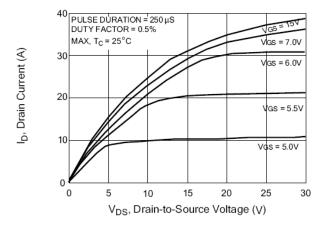


Figure 3. Maximum Continuous Drain Current vs Case Temperature

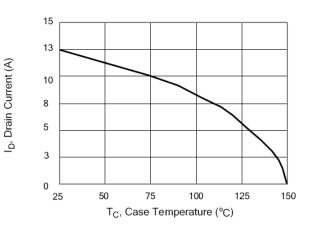
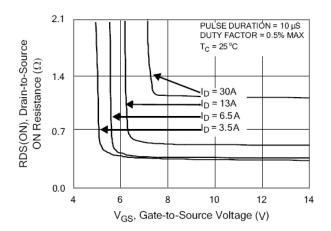
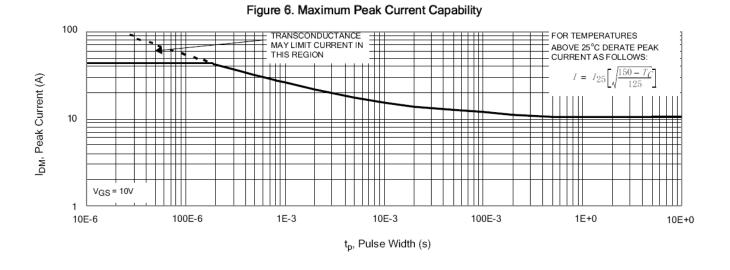


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current





I_{AS}, Avalanche Current (A)

Figure 7. Typical Transfer Characteristics

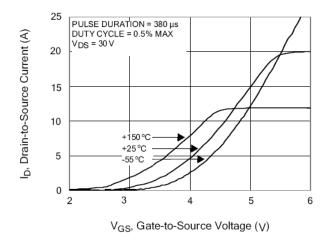


Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current

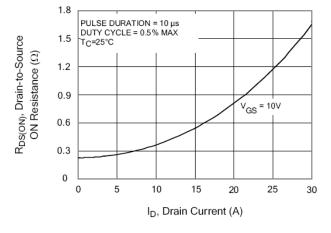


Figure 8. Unclamped Inductive Switching Capability

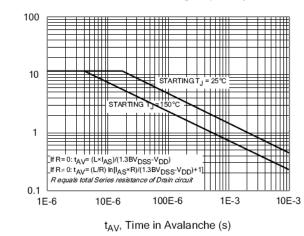
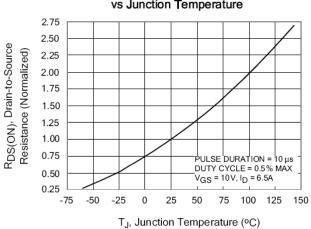


Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature





Typical Characteristics(Cont.)

Figure 11. Typical Breakdown Voltage vs Junction Temperature

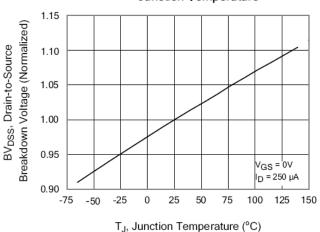
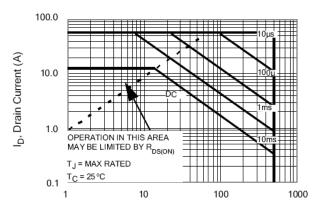


Figure 13. Maximum Forward Bias Safe Operating Area



V_{DS}, Drain-to-Source Voltage (V)

Figure 15. Typical Gate Charge vs Gate-to-Source Voltage

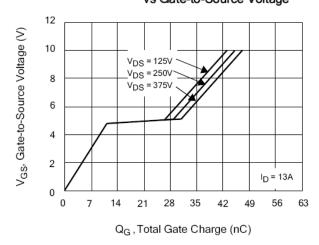


Figure 12. Typical Threshold Voltage vs Junction Temperature

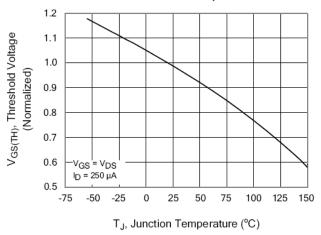


Figure 14. Typical Capacitance vs Drain-to-Source Voltage

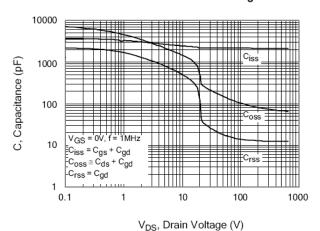
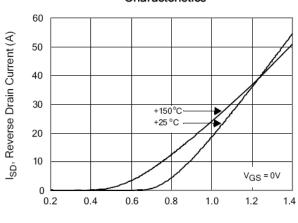


Figure 16. Typical Body Diode Transfer Characteristics



 V_{SD} , Source-to-Drain Voltage (V)

Test Circuits and Waveforms

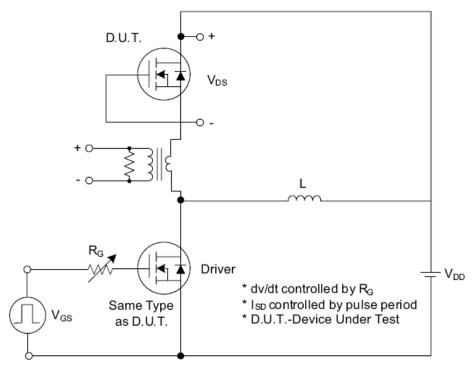


Fig. 1.1 Peak Diode Recovery dv/dt Test Circuit

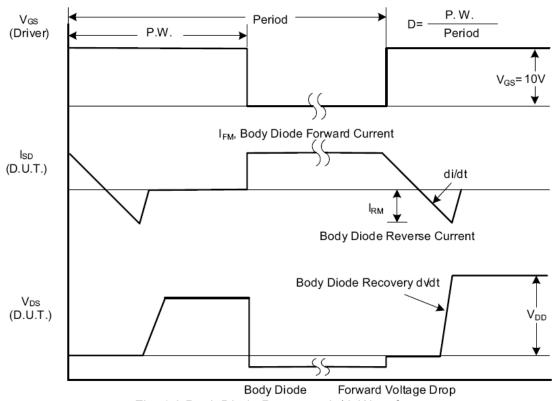


Fig. 1.2 Peak Diode Recovery dv/dt Waveforms

Test Circuits and Waveforms (Cont.)

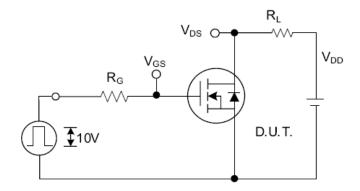


Fig. 2.1 Switching Test Circuit

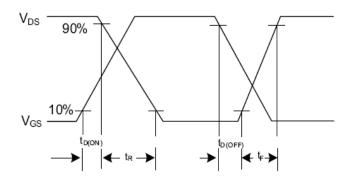


Fig. 2.2 Switching Waveforms

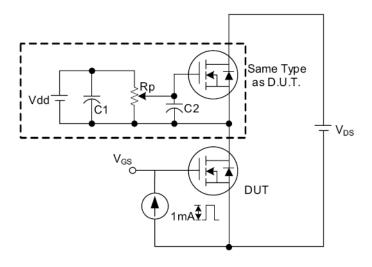


Fig. 3 . 1 Gate Charge Test Circuit

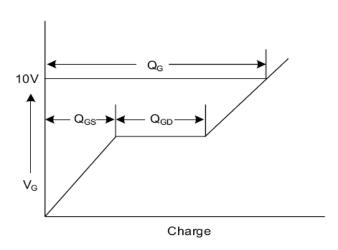


Fig. 3.2 Gate Charge Waveform

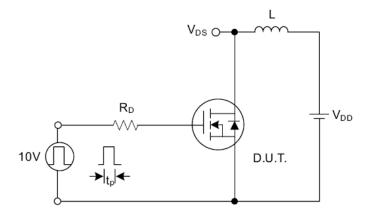


Fig. 4.1 Unclamped Inductive Switching Test Circuit

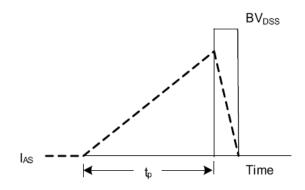
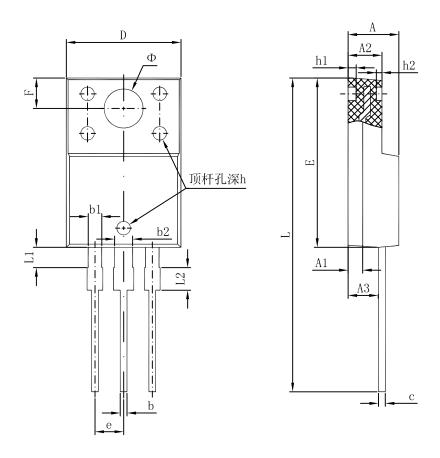


Fig. 4.2 Unclamped Inductive Switching Waveforms



Package Dimension TO-220F



Symbol	Dimensions In Millimeters		Dimensions In Inches			
	Min.	Max.	Min.	Max.		
Α	4.300	4.700	0.169	0.185		
A1	1.300	1.300 REF.		0.051 REF.		
A2	2.800	3.200	0.110	0.126		
A3	2.500	2.900	0.098	0.114		
b	0.500	0.750	0.020	0.030		
b1	1.100	1.350	0.043	0.053		
b2	1.500	1.750	0.059	0.069		
С	0.500	0.750	0.020	0.030		
D	9.960	10.360	0.392	0.408		
Е	14.800	15.200	0.583	0.598		
е	2.540 TYP.		0.100 TYP.			
F	2.700 REF.		0.106 REF.			
Φ	3.500 REF.		0.138 REF.			
h	0.000	0.300	0.000	0.012		
h1	0.800 REF.		0.031 REF.			
h2	0.500 REF.		0.020 REF.			
L	28.000	28.400	1.102	1.118		
L1	1.700	1.900	0.067	0.075		
L2	1.900	2.100	0.075	0.083		



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